

Search Notes**Application/Control No.**

10/777,822

Examiner

Faye Polyzos

Applicant(s)/Patent under Reexamination

MIYANO ET AL.

Art Unit

2884

SEARCHED

Class	Subclass	Date	Examiner
250	330	2/7/2006	FP
250	38.1	2/7/2006	FP
250	342	2/7/2006	FP
250	349	2/7/2006	FP
250	350	2/7/2006	FP
250	353	2/7/2006	FP
250	338.3	2/7/2006	FP
359	350	2/7/2006	FP
359	356	2/7/2006	FP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB,USPAT,EPO,JPO, DERWENT) – See Search History Printout	2/7/2006	FP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner